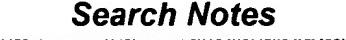


<b>Search Notes</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/845,382	HAYASHI ET AL.
	Examiner Kimnhung Nguyen	Art Unit 2677

**SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner